

**Notice of References Cited**

Application/Control No.

10/643,102

Applicant(s)/Patent Under  
Reexamination  
KRIER ET AL.

Examiner

Minh D. A

Art Unit

2821

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,597,318	07-2003	Parsche et al.	343/700MS
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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